

INTERNATIONAL STANDARD

IEC 61587-2

First edition
2000-12

Mechanical structures for electronic equipment – Tests for IEC 60917 and IEC 60297 –

Part 2: Seismic tests for cabinets and racks

*Structures mécaniques pour équipement électronique –
Essais pour la CEI 60917 et la CEI 60297 –*

*Partie 2:
Essais sismiques pour baies et bâtis*

IEC 61587-2:2000

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

MECHANICAL STRUCTURES FOR ELECTRONIC EQUIPMENT – TESTS FOR IEC 60917 AND IEC 60297 –

Part 2: Seismic tests for cabinets and racks

FOREWORD

- 1) The IEC (International Electrotechnical Commission) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of the IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, the IEC publishes International Standards. Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. The IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of the IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested National Committees.
- 3) The documents produced have the form of recommendations for international use and are published in the form of standards, technical specifications, technical reports or guides and they are accepted by the National Committees in that sense.
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- 6) Attention is drawn to the possibility that some of the elements of this International Standard may be the subject of patent rights. The IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61587-2 has been prepared by subcommittee 48D: Mechanical structures for electronic equipment, of IEC technical committee 48: Electromechanical components and mechanical structures for electronic equipment.

The text of this standard is based on the following documents:

| FDIS | Report on voting |
|--------------|------------------|
| 48D/236/FDIS | 48D/245/RVD |

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 3.

IEC 61587 consists of the following parts under the general title *Mechanical structures for electronic equipment – Tests for IEC 60917 and IEC 60297*:

Part 1: Climatic, mechanical tests and safety aspects for cabinets, racks, subracks and chassis

Part 2: Seismic tests for cabinets and racks

Part 3: Electromagnetic shielding performance tests for cabinets, racks and subracks

The committee has decided that the contents of this publication will remain unchanged until 2006. At this date, the publication will be

- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

A bilingual version of this standard may be issued at a later date.

Withdawn

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MECHANICAL STRUCTURES FOR ELECTRONIC EQUIPMENT – TESTS FOR IEC 60917 AND IEC 60297 –

Part 2: Seismic tests for cabinets and racks

1 Scope and object

This part of IEC 61587 specifies seismic requirements for cabinets or racks as defined in the IEC 60917 and IEC 60297 series. It applies, in whole or in part, only to the mechanical structures of cabinets or racks for electronic equipment, according to the IEC 60297 and the IEC 60917 series, and does not apply to electronic equipment or systems within the mechanical structures.

The object of this standard is to help ensure physical integrity and environmental performance in mechanical cabinets or racks, taking into account the need for different levels of performance in different applications and geographical regions. It is intended to give the user a high level of confidence in the selection of an equipment practice to meet specific needs. A specific test specimen has been selected (see figure 1).

2 Normative references

The following normative documents contain provisions which, through reference in this text, constitute provisions of this part of IEC 61587. For dated references, subsequent amendments to, or revisions of, any of these publications do not apply. However, parties to agreements based on this part of IEC 61587 are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. For undated references, the latest edition of the normative document referred to applies. Members of IEC and ISO maintain registers of currently valid International Standards.

IEC 60068-2-6:1995, *Environmental testing – Part 2: Tests – Test Fc: Vibration (sinusoidal)*

IEC 60068-2-47:1999, *Environmental testing – Part 2-47: Test method – Mounting of components, equipment and other articles for vibration, impact and similar dynamic tests*

IEC 60068-2-57:1999, *Environmental testing – Part 2-57: Tests – Test Ff: Vibration – Time-history method*

IEC 60068-3-3:1991, *Environmental testing – Part 3: Guidance – Seismic test methods for equipment*

IEC 60297-1, *Dimensions of mechanical structures of the 482,6 mm (19 in) series – Part 1: Panels and racks*

IEC 60297-2, *Dimensions of mechanical structures of the 482,6 mm (19 in) series – Part 2: Cabinets and pitches of rack structures*

IEC 60297-3, *Dimensions of mechanical structures of the 482,6 mm (19 in) series – Part 3: Subracks and associated plug-in units*

IEC 60297-4, *Mechanical structures for electronic equipment – Dimensions of mechanical structures of the 482,6 mm (19 in) series – Part 4: Subracks and associated plug-in units – Additional dimensions*